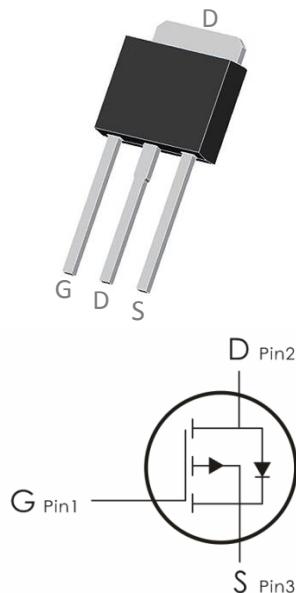


Description:

This P-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=-60V, I_D=-35A, R_{DS(on)}<28m\Omega @ V_{GS}=-10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	-60	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current	-35	A
	Continuous Drain Current- $T_C=100^\circ C$	-22.1	
	Pulsed Drain Current ¹	-140	
E_{AS}	Single Pulse Avalanche Energy	---	mJ
P_D	Power Dissipation	72.6	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
R_{eJC}	Thermal Resistance,Junction to Case	1.72	$^\circ C/W$
R_{eJA}	Thermal Resistance,Junction to Ambient	62	

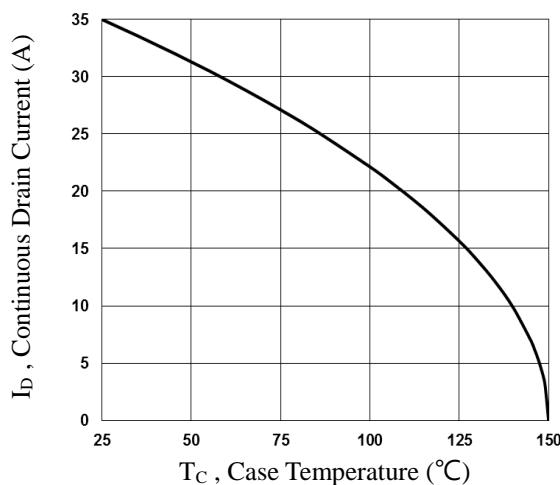
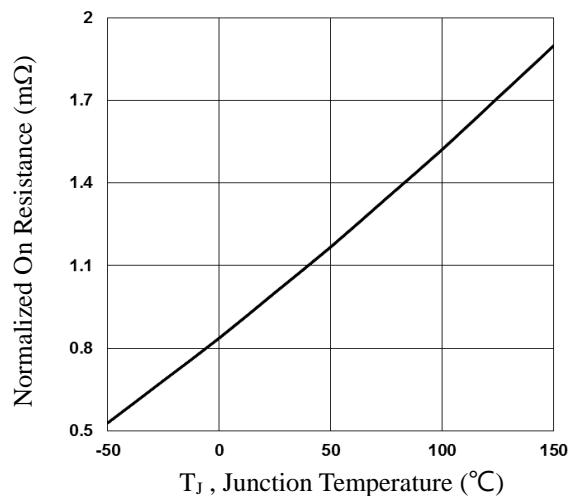
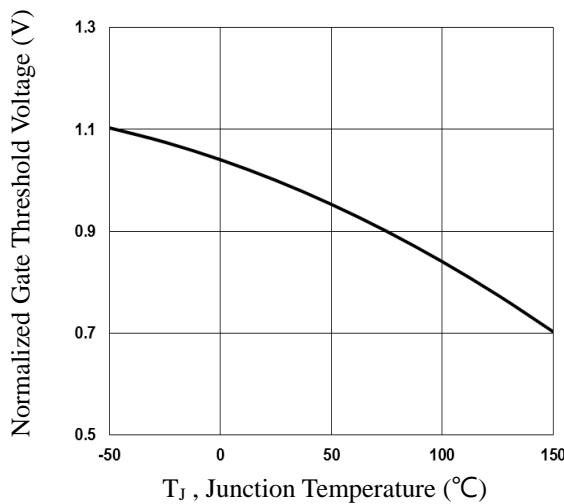
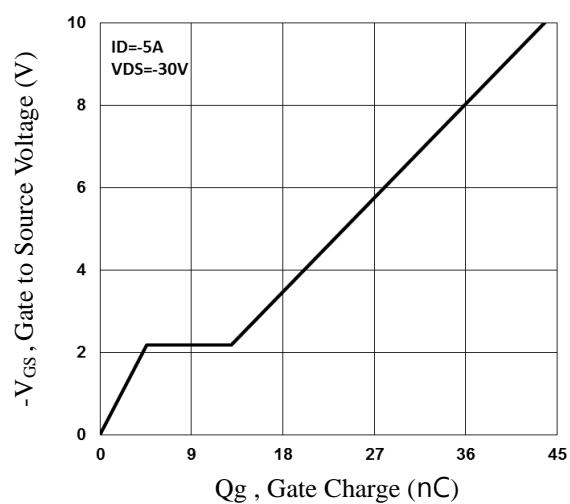
Electrical Characteristics: ($T_c=25^\circ\text{C}$ unless otherwise noted)

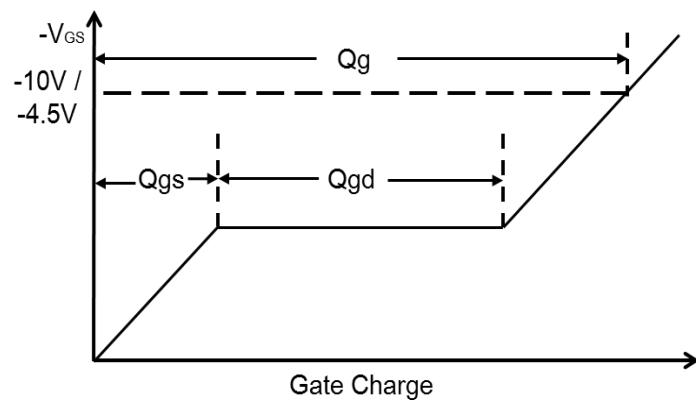
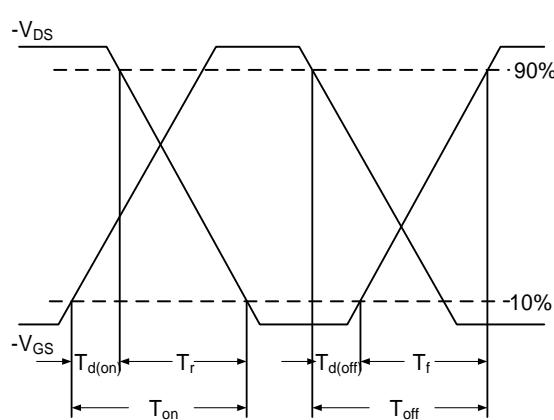
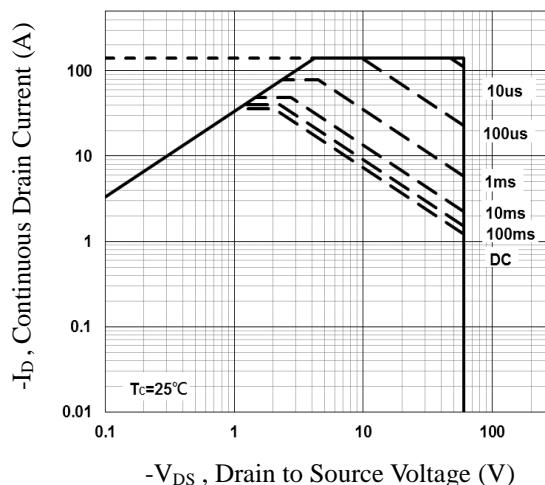
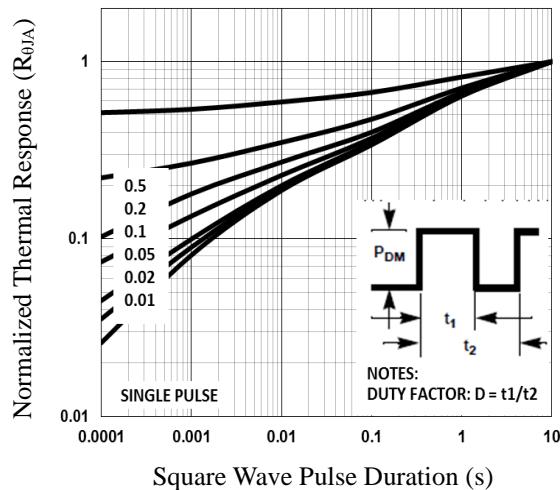
Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	-60	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-60\text{V}$	---	---	-1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	---	± 100	nA
On Characteristics						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	-1	-1.6	-2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-8\text{A}$	---	22	28	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-6\text{A}$	---	26	35	
G_{FS}	Forward Transconductance	$V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-3\text{A}$	---	18	---	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=-25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	2595	3900	pF
C_{oss}	Output Capacitance		---	162	240	
C_{rss}	Reverse Transfer Capacitance		---	115	170	
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time ^{2,3}	$V_{\text{DS}}=-30\text{V}, I_{\text{D}}=-1\text{A}, R_{\text{GEN}}=6 \Omega, V_{\text{GS}}=-10\text{V}$	---	25	50	ns
t_r	Rise Time ^{2,3}		---	13.8	28	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time ^{2,3}		---	148	290	ns
t_f	Fall Time ^{2,3}		---	51	100	ns
Q_g	Total Gate Charge ^{2,3}	$V_{\text{GS}}=-10\text{V}, V_{\text{DS}}=-30\text{V}, I_{\text{D}}=-5\text{A}$	---	43.8	88	nC
Q_{gs}	Gate-Source Charge ^{2,3}		---	4.6	9	nC
Q_{gd}	Gate-Drain "Miller" Charge ^{2,3}		---	8.3	17	nC
Drain-Source Diode Characteristics						
V_{SD}	Source-Drain Diode Forward Voltage ²	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=-1\text{A}, T_j=25^\circ\text{C}$	---	---	-1	V

I_s	Continuous Source Current $V_G=V_D=0V$, Force Current	---	---	-35	A
I_{sm}	Pulsed Source Current ³	---	---	-70	A

Notes:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
3. Essentially independent of operating temperature.

Typical Characteristics: ($T_C=25^\circ C$ unless otherwise noted)

Fig.1 Continuous Drain Current vs. T_C

Fig.2 Normalized $R_{DS(on)}$ vs. T_J

Fig.3 Normalized V_{th} vs. T_J

Fig.4 Gate Charge Waveform



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